

T-46-23-12

Ordering number: EN3752

CMOS LSI



LC3517B, BM, BS, BL, BML, BSL
2048-word × 8-bit CMOS Static RAM

OVERVIEW

LC3517B series devices are silicon-gate CMOS, static RAM ICs configured as 2048 words × 8 bits. They incorporate an output enable for high-speed memory access, and TTL-compatible, tristate outputs for direct interfacing with a bus.

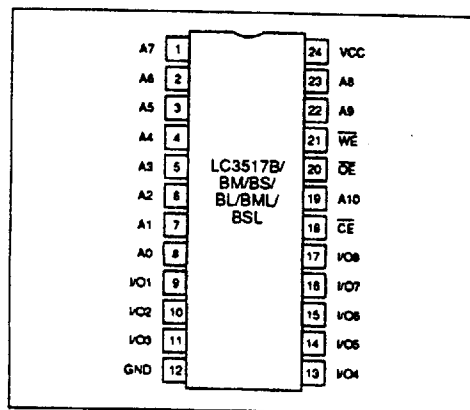
LC3517B series ICs feature a data retention mode and a low standby current, making them ideal for low-power or battery-powered equipment. In particular, the LC3517BL, LC3517BML and LC3517BSL offer a guaranteed maximum standby current of 1 μA at 60 deg. C.

LC3517B series ICs operate from a 5 V supply and are available in 24-pin DIPs, 24-pin MFPs and 24-pin SDIPs.

FEATURES

- 120 ns (LC3517B-12 series) and 150 ns (LC3517B-15 series) maximum address access times
- 0.2 μA at 25 deg. C and 1.0 μA at 60 deg. C (LC3517BL/BML/BSL-12/15), and 5.0 μA at 60 deg. C and 30 μA at 85 deg. C (LC3517B/BM/BS-12/15) maximum standby currents
- 9 mA maximum supply current at f = 1 MHz
- Data retention for V_{cc} = 2.0 to 5.5 V
- Asynchronous operation
- TTL-compatible, tristate input/outputs
- Single 5 V supply
- 24-pin DIP, 24-pin MFP and 24-pin SDIP

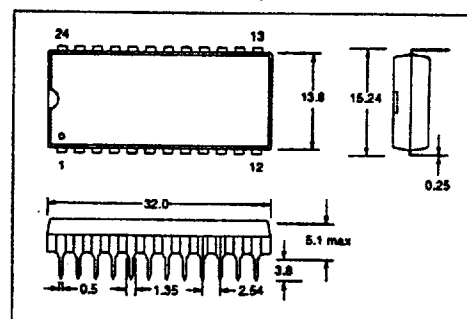
PINOUT



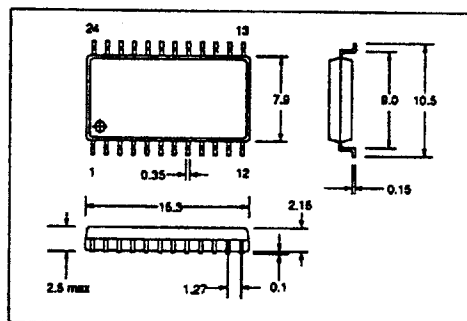
PACKAGE DIMENSIONS

Unit: mm

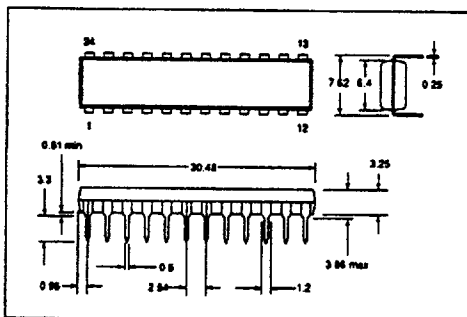
3072-DIP24NS (LC3517B/BL)



3045B-MFP24 (LC3517BM/BML)



3114-DIP24NS 300 mil (LC3517BS/BSL)

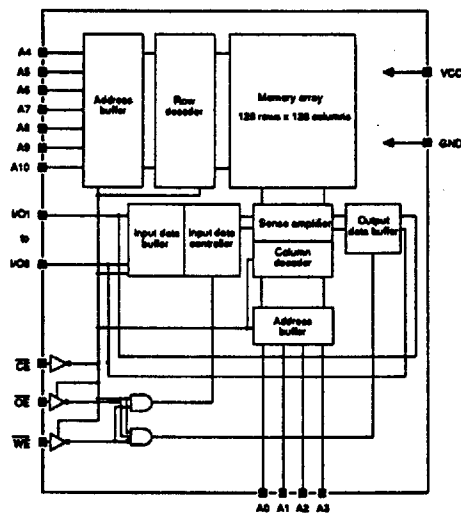


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No. 3752—1/6

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BLOCK DIAGRAM



PIN DESCRIPTION

Number	Name	Description
1 to 8, 19, 22, 23	A0 to A10	Address inputs
9 to 11, 13 to 17	I/O1 to I/O8	Data inputs/outputs
12	GND	Ground
18	\overline{CE}	Chip enable input
20	\overline{OE}	Output enable input
21	\overline{WE}	Read/write select input
24	VCC	5 V supply

SPECIFICATIONS

Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
Supply voltage	VCC max	7.0	V
Input voltage range	V _{IN}	-0.5 to VCC + 0.5	V
Input/output voltage range	V _{IO}	-0.5 to VCC + 0.5	V
Operating temperature range	T _{OPG}	-30 to 85	deg. C
Storage temperature range	T _{STG}	-55 to 125	deg. C

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Recommended Operating Conditions

 $T_a = 25 \text{ deg. C}$

Parameter	Symbol	Rating	Unit
Supply voltage	V_{CC}	5.0	V
Supply voltage range	$V_{CC \text{ op}}$	4.5 to 5.5	V

Electrical Characteristics

 $V_{CC} = 5 \text{ V} \pm 10\%$, $T_a = -30 \text{ to } 85 \text{ deg. C}$ unless otherwise noted

Parameter	Symbol	Condition	Rating			Unit	
			min	typ	max		
Quiescent supply current	I_{CC1}	$V_{EE} = 0 \text{ V}$, $V_{IH} = V_{CC}$ or GND, $I_{VO} = 0 \text{ mA}$	-	2	5	mA	
		$V_{EE} = V_{IL}$, $V_{IH} = V_{IH}$ or V_{IL} , $I_{VO} = 0 \text{ mA}$	-	5	15		
Average supply current	I_{CC2}	Minimum cycle time, duty = 100%, $I_{VO} = 0 \text{ mA}$	-	-	50	mA	
		Cycle time = 1 μs , $V_{EE} = 0 \text{ V}$, $V_{IH} = V_{CC}$ or GND, $I_{VO} = 0 \text{ mA}$	-	4	9		
Standby supply current	I_{CC3}	$V_{EE} = V_{CC} - 0.2 \text{ V}$, $V_{IH} = 0 \text{ V}$ to V_{CC} . See note 1.	$T_a = 60 \text{ deg. C}$	-	-	5.0	μA
			$T_a = 85 \text{ deg. C}$	-	-	30	
		$V_{EE} = V_{CC} - 0.2 \text{ V}$, $V_{IH} = 0 \text{ V}$ to V_{CC} . See note 2.	$T_a = 25 \text{ deg. C}$	-	-	0.2	
			$T_a = 60 \text{ deg. C}$	-	-	1.0	
		$V_{EE} = V_{IH}$, $V_{IH} = 0 \text{ V}$ to V_{CC}	-	1.0	3.0	mA	
LOW-level input voltage	V_{IL}		-0.3	-	0.8	V	
HIGH-level input voltage	V_{IH}		2.2	-	$V_{CC} + 0.3$	V	
LOW-level output voltage	V_{OL}	$I_{OL} = 2.0 \text{ mA}$	-	-	0.4	V	
HIGH-level output voltage	V_{OH}	$I_{OH} = -1.0 \text{ mA}$	2.4	-	-	V	
Input capacitance	C_{IN}	$V_{IH} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_a = 25 \text{ deg. C}$	-	-	5	pF	
Input/output capacitance	C_{VO}	$V_{VO} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_a = 25 \text{ deg. C}$	-	-	10	pF	
Input leakage current	I_{LI}	$V_{IH} = 0$ to V_{CC}	-1.0	-	1.0	μA	
Input/output leakage current	I_{LO}	V_{EE} or $V_{EE} = V_{IH}$, $V_{VO} = 0 \text{ V}$ to V_{CC}	-5.0	-	5.0	μA	

Notes

- LC3517B/BM/BS-12/15
- LC3517BL/BML/BSL-12/15
- Typical values are measured at $V_{CC} = 5.0 \text{ V}$ and $T_a = 25 \text{ deg. C}$.

Timing Characteristics

Test conditions

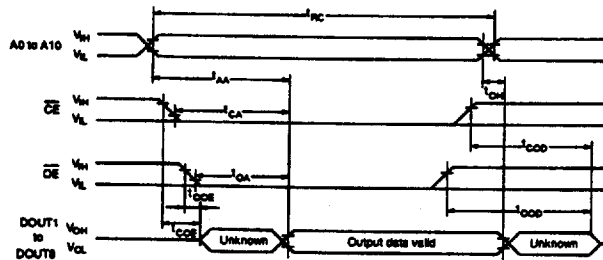
- LOW-level pulse—0.6 V
- HIGH-level pulse—2.4 V
- Input rise and fall times—5 ns
- LOW-level timing reference— $V_{IL} = V_{OL} = 0.8 \text{ V}$

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- HIGH-level timing reference— $V_{DH} = V_{OH} = 2.2\text{ V}$
- Output load—1 TTL gate + $C_L = 100\text{ pF}$ (including jig capacitance)

Read timing

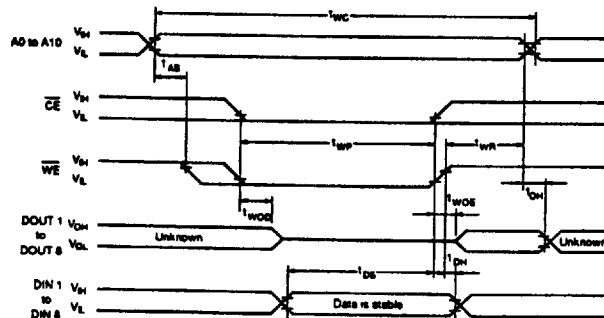


$V_{CC} = 5\text{ V} \pm 10\%$, $T_A = -30\text{ to }85\text{ deg. C}$

Parameter	Symbol	LC3517B/BM/BS-12, LC3517BL/BML/BSL-12		LC3517B/BM/BS-15, LC3517BL/BML/BSL-15		Unit
		min	max	min	max	
Read cycle time	t_{AC}	120	-	150	-	ns
Address access time	t_{AA}	-	120	-	150	ns
Output-enable access time	t_{OA}	-	70	-	80	ns
Chip-enable access time	t_{CA}	-	120	-	150	ns
Output hold time	t_{OH}	20	-	20	-	ns
Output-enable propagation delay	t_{OE}	5	-	5	-	ns
Chip-enable propagation delay	t_{COE}	10	-	10	-	ns
Output-disable propagation delay	t_{OD}	-	40	-	50	ns
Chip-disable propagation delay	t_{COD}	-	40	-	50	ns

Write timing

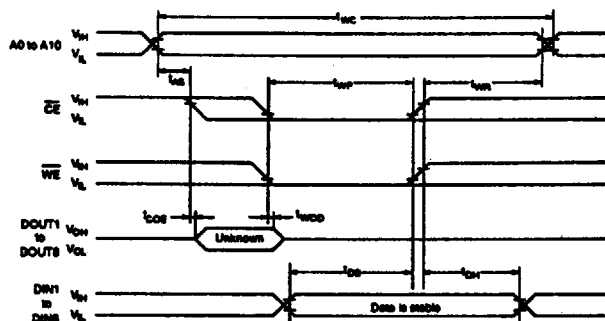
Write cycle 1



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Write cycle 2



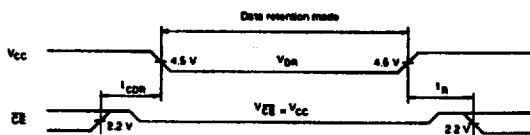
V_{cc} = 5 V ±10%, T_a = -30 to 85 deg. C

Parameter	Symbol	LC3517B/BM/BS-12, LC3517BL/BML/BSL-12		LC3517B/BM/BS-15, LC3517BL/BML/BSL-15		Unit
		min	max	min	max	
Write cycle time	t _{bc}	120	-	150	-	ns
Address setup time	t _{cs}	0	-	0	-	ns
Write pulsewidth	t _{wp}	100	-	120	-	ns
Write recovery time	t _{wr}	0	-	0	-	ns
Data setup time	t _{ps}	60	-	70	-	ns
Data hold time	t _{ph}	0	-	0	-	ns
Write-enable propagation delay	t _{wde}	5	-	5	-	ns
Write-disable propagation delay	t _{wod}	-	40	-	50	ns

Notes

1. Hold **WE** HIGH during the read cycle.
2. Do not apply opposite phase signals to **DOUT** when it is connected to the output bus.
3. t_{wp} is measured when **CE** and **WE** are LOW.
4. t_{wr}, t_{ps} and t_{ph} are measured when **CE** or **WE** is HIGH.
5. **DOUT** becomes high impedance when either **CE** or **OE** is HIGH, or **WE** is LOW.
6. t_{cs} is measured when **CE** and **WE** are LOW.
7. **DOUT** is high impedance when **OE** is HIGH during the write cycle.
8. **DOUT** has the same phase as the data to be written during the write cycle.
9. **DOUT** is the data read out from the next address.

Data Retention Characteristics



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T_a = -30 to 85 deg. C

Parameter	Symbol	Condition	Rating			Unit	
			min	typ	max		
Data retention mode supply voltage	V _{DR}	V _{CE} = V _{CC} , V _{IN} = 0 V to V _{CC}	2.0	-	5.5	V	
Data retention mode supply current	I _{CCDR}	V _{CE} = V _{CC} , V _{CC} = 3.0 V, V _{IN} = 0 V to V _{CC} . See note 1.	T _a = 60 deg. C	-	-	4.0	μA
			T _a = 85 deg. C	-	-	20	
		V _{CE} = V _{CC} , V _{CC} = 3.0 V, V _{IN} = 0 V to V _{CC} . See note 2.	T _a = 25 deg. C	-	-	0.2	
			T _a = 60 deg. C	-	-	1.0	
Chip-enable setup time	t _{CON}		0	-	-	ns	
Chip-enable hold time	t _H		t _{CH}	-	-	ns	

Notes

1. LC3517B/BM/BS-12/15
2. LC3517BL/BML/BSL-12/15

Mode Selection

Mode	\overline{CE}	\overline{DE}	\overline{WE}	I/O1 to I/O8	Supply current
Read	L	L	H	Data input	I _{CCA}
Write	L	X	L	Data output	I _{CCA}
Output disable	L	H	X	High impedance	I _{CCA}
Standby	H	X	X	High impedance	I _{CCS}

Note

X = don't care

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